Search Notes



_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/771,464	VANTTINEN ET	AL.
	Examiner	Art Unit	
	Hanh Nguyen	2668	

SEARCHED					
Class	Subclass	Date	Examiner		
370	329	12/20/05	HN		
	328				
	331				
	332				
	410				
	426				
	338				
455	422.1				
	404.2				
	412.1				
	456.1				
	456.2				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			'		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	12/20/2005	HN	